

MOSFET – N-Channel, POWERTRENCH®

30 V, 9.0 A, 16 m Ω

FDMA8878, FDMA8878-F130

General Description

This N-Channel MOSFET is produced using **onsemi**'s advanced POWERTRENCH process that has been optimized for $R_{DS(on)}$, switching performance.

Features

- Max $R_{DS(on)} = 16 \text{ m}\Omega$ @ $V_{GS} = 10 \text{ V}$, $I_D = 9.0 \text{ A}$
- Max $R_{DS(on)} = 19 \text{ m}\Omega$ @ $V_{GS} = 4.5 \text{ V}$, $I_D = 8.5 \text{ A}$
- High Performance Trench Technology for Extremely Low R_{DS(on)}
- Fast Switching Speed
- Pb-Free, Halide Free and RoHS Compliant

Applications

- DC-DC Buck Converters
- Load Switch in NB
- Notebook Battery Power Management

ABSOLUTE MAXIMUM RATINGS

 $T_A = 25^{\circ}C$ unless otherwise noted.

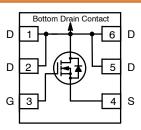
Symbol	Parameter	Ratings	Unit
V_{DS}	Drain to Source Voltage	30	V
V _{GS}	Gate to Source Voltage (Note 3)	±20	V
Ι _D	Drain Current Continuous (Package Limited), T _C = 25°C Continuous, T _A = 25°C (Note 1a) Pulsed	10 9.0 40	A
P _D	Power Dissipation, T _A = 25°C (Note 1a) (Note 1b)	2.4 0.9	W
T _J , T _{STG}	Operating and Storage Junction Temperature Range	-55 to +150	°C

Stresses exceeding those listed in the Maximum Ratings table may damage the device. If any of these limits are exceeded, device functionality should not be assumed, damage may occur and reliability may be affected.

THERMAL CHARACTERISTICS

Symbol	Parameter	Ratings	Unit
$R_{\theta JA}$	Thermal Resistance, Junction to Ambient (Note 1a)	52	°C/W
	(Note 1b)	145	



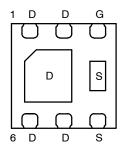


MARKING DIAGRAM



Z = Assembly Plant Code
XY = 2-Digit Date Code
KK = Lot Run Code
878 = Specific Device Code

PIN ASSIGNMENT



ORDERING INFORMATION

See detailed ordering and shipping information on page 5 of this data sheet.

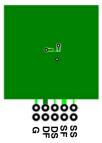
ELECTRICAL CHARACTERISTICS $T_A = 25^{\circ}C$ unless otherwise noted.

$\begin{array}{c} \textbf{OFF CHARAC}\\ \textbf{BV}_{DSS}\\ \hline \Delta \textbf{BV}_{DSS}\\ \hline \Delta \textbf{T}_J\\ \textbf{I}_{DSS}\\ \textbf{I}_{GSS}\\ \textbf{ON CHARAC}\\ \hline \textbf{V}_{GS(th)}\\ \hline \Delta \textbf{T}_J\\ \hline \textbf{R}_{DS(on)}\\ \hline \\ \textbf{GSS}\\ \hline \textbf{DYNAMIC CH}\\ \hline \textbf{C}_{iss}\\ \hline \textbf{C}_{oss}\\ \end{array}$	Drain to Source Breakdown Voltage Breakdown Voltage Temperature Coefficient Zero Gate Voltage Drain Current Gate—Body Leakage	$\begin{split} I_D &= 250 \ \mu\text{A}, \ V_{GS} = 0 \ \text{V} \\ I_D &= 250 \ \mu\text{A}, \ \text{Referenced to } 25^\circ\text{C} \\ V_{DS} &= 24 \ \text{V}, \ V_{GS} = 0 \ \text{V} \\ V_{GS} &= \pm 20 \ \text{V}, \ V_{DS} = 0 \ \text{V} \\ \end{split}$ $\begin{split} V_{DS} &= V_{GS}, \ I_D = 250 \ \mu\text{A} \\ I_D &= 250 \ \mu\text{A}, \ \text{Referenced to } 25^\circ\text{C} \\ \end{split}$ $\begin{split} I_D &= 9.0 \ \text{A}, \ V_{GS} = 10 \ \text{V}, \\ I_D &= 8.5 \ \text{A}, \ V_{GS} = 4.5 \ \text{V} \\ I_D &= 9.0 \ \text{A}, \ V_{GS} = 10 \ \text{V}, \\ T_J &= 125^\circ\text{C} \\ \end{split}$ $\begin{split} V_{DD} &= 5 \ \text{V}, \ I_D = 9.0 \ \text{A} \end{split}$	30 - - - - 1.2 - -	- 26 1.8 -5 13 16 17	3.0 - 16 19 21	V mV/°C μA nA V mV/°C
$\frac{\Delta BV_{DSS}}{\Delta T_J}$ I_{DSS} I_{GSS} $DN CHARAC$ $V_{GS(th)}$ $\frac{\Delta V_{GS(th)}}{\Delta T_J}$ $R_{DS(on)}$ g_{FS} $DYNAMIC CH$ C_{iss}	Breakdown Voltage Temperature Coefficient Zero Gate Voltage Drain Current Gate—Body Leakage TERISTICS Gate to Source Threshold Voltage Gate to Source Threshold Voltage Temperature Coefficient Static Drain to Source On—Resistance Forward Transconductance	$\begin{split} &I_D = 250 \ \mu\text{A}, \\ &Referenced \ to \ 25^{\circ}\text{C} \\ &V_{DS} = 24 \ \text{V}, \ V_{GS} = 0 \ \text{V} \\ &V_{GS} = \pm 20 \ \text{V}, \ V_{DS} = 0 \ \text{V} \\ &V_{DS} = V_{GS}, \ I_D = 250 \ \mu\text{A} \\ &I_D = 250 \ \mu\text{A}, \ Referenced \ to \ 25^{\circ}\text{C} \\ &I_D = 9.0 \ \text{A}, \ V_{GS} = 10 \ \text{V}, \\ &I_D = 8.5 \ \text{A}, \ V_{GS} = 4.5 \ \text{V} \\ &I_D = 9.0 \ \text{A}, \ V_{GS} = 10 \ \text{V}, \\ &T_J = 125^{\circ}\text{C} \end{split}$		1.8 -5 13 16	3.0 - 16 19	mV/°C μA nA V mV/°C
IDSS IGSS ON CHARAC VGS(th) ΔVGS(th) ΔTJ RDS(on) GFS DYNAMIC CH	Coefficient Zero Gate Voltage Drain Current Gate—Body Leakage TERISTICS Gate to Source Threshold Voltage Gate to Source Threshold Voltage Temperature Coefficient Static Drain to Source On—Resistance Forward Transconductance	Referenced to 25°C $V_{DS} = 24 \text{ V}, V_{GS} = 0 \text{ V}$ $V_{GS} = \pm 20 \text{ V}, V_{DS} = 0 \text{ V}$ $V_{DS} = V_{GS}, I_D = 250 \text{ μA}$ $I_D = 250 \text{ μA}, \text{ Referenced to } 25^{\circ}\text{C}$ $I_D = 9.0 \text{ A}, V_{GS} = 10 \text{ V},$ $I_D = 8.5 \text{ A}, V_{GS} = 4.5 \text{ V}$ $I_D = 9.0 \text{ A}, V_{GS} = 10 \text{ V},$ $T_J = 125^{\circ}\text{C}$	1.2	1.8 -5 13 16	3.0 - 16 19	μA nA V mV/°C
$\begin{array}{c} I_{GSS} \\ \hline \textbf{DN CHARAC} \\ \hline V_{GS(th)} \\ \hline \Delta V_{GS(th)} \\ \hline \Delta T_J \\ \hline R_{DS(on)} \\ \hline \\ \hline \textbf{GFS} \\ \hline \textbf{DYNAMIC CH} \\ \hline C_{iss} \\ \hline \end{array}$	Gate-Body Leakage TERISTICS Gate to Source Threshold Voltage Gate to Source Threshold Voltage Temperature Coefficient Static Drain to Source On-Resistance Forward Transconductance	$\begin{split} V_{GS} = \pm 20 \ \text{V}, V_{DS} = 0 \ \text{V} \\ \\ V_{DS} = V_{GS}, I_D = 250 \ \mu\text{A} \\ \\ I_D = 250 \ \mu\text{A}, \text{ Referenced to } 25^{\circ}\text{C} \\ \\ I_D = 9.0 \ \text{A}, V_{GS} = 10 \ \text{V}, \\ \\ I_D = 8.5 \ \text{A}, V_{GS} = 4.5 \ \text{V} \\ \\ I_D = 9.0 \ \text{A}, V_{GS} = 10 \ \text{V}, \\ \\ T_J = 125^{\circ}\text{C} \end{split}$	1.2	1.8 -5 13 16	3.0 - 16 19	nA V mV/°C
$\begin{array}{c} \textbf{DN CHARAC} \\ \textbf{V}_{GS(th)} \\ \hline \Delta \textbf{V}_{GS(th)} \\ \hline \Delta \textbf{T}_{J} \\ \hline \textbf{R}_{DS(on)} \\ \\ \hline \\ \textbf{GS(on)} \\ \\ \hline \\ \textbf{GS(th)} \\ \hline \Delta \textbf{T}_{J} \\ \hline \\ \textbf{R}_{DS(on)} \\ \\ \hline \\ \textbf{GS(on)} \\ \\ \textbf{GS(on)} \\ \\ \hline \\ \textbf{GS(on)} \\ \\ \\ \textbf{GS(on)} \\ \\ \textbf{GS(on)} \\ \\ \\ \textbf{GS(on)} \\ \\ \\ \textbf{GS(on)} \\ \\ \\ \textbf{GS(on)} \\ \\ $	Gate to Source Threshold Voltage Gate to Source Threshold Voltage Temperature Coefficient Static Drain to Source On–Resistance Forward Transconductance	$\begin{split} &V_{DS} = V_{GS}, I_D = 250 \; \mu A \\ &I_D = 250 \; \mu A, \; \text{Referenced to } 25^{\circ}\text{C} \\ \\ &I_D = 9.0 \; A, \; V_{GS} = 10 \; V, \\ &I_D = 8.5 \; A, \; V_{GS} = 4.5 \; V \\ \\ &I_D = 9.0 \; A, \; V_{GS} = 10 \; V, \\ &T_J = 125^{\circ}\text{C} \end{split}$	1.2	1.8 -5 13 16	3.0 - 16 19	V mV/°C
$\frac{V_{GS(th)}}{\Delta V_{GS(th)}}$ $\frac{\Delta V_{GS(th)}}{\Delta T_J}$ $R_{DS(on)}$ g_{FS} $DYNAMIC~CH$ C_{iss}	Gate to Source Threshold Voltage Gate to Source Threshold Voltage Temperature Coefficient Static Drain to Source On–Resistance Forward Transconductance	$\begin{split} I_D &= 250~\mu\text{A},~\text{Referenced to}~25^{\circ}\text{C} \\ \\ I_D &= 9.0~\text{A},~\text{V}_{GS} = 10~\text{V}, \\ \\ I_D &= 8.5~\text{A},~\text{V}_{GS} = 4.5~\text{V} \\ \\ I_D &= 9.0~\text{A},~\text{V}_{GS} = 10~\text{V}, \\ \\ T_J &= 125^{\circ}\text{C} \end{split}$	- - -	-5 13 16	- 16 19	mV/°C
$\frac{\Delta V_{GS(th)}}{\Delta T_J}$ $R_{DS(on)}$ $\frac{g_{FS}}{DYNAMIC~CH}$	Gate to Source Threshold Voltage Temperature Coefficient Static Drain to Source On–Resistance Forward Transconductance	$\begin{split} I_D &= 250~\mu\text{A},~\text{Referenced to}~25^{\circ}\text{C} \\ \\ I_D &= 9.0~\text{A},~\text{V}_{GS} = 10~\text{V}, \\ \\ I_D &= 8.5~\text{A},~\text{V}_{GS} = 4.5~\text{V} \\ \\ I_D &= 9.0~\text{A},~\text{V}_{GS} = 10~\text{V}, \\ \\ T_J &= 125^{\circ}\text{C} \end{split}$	- - -	-5 13 16	- 16 19	mV/°C
$\frac{\Delta V_{GS(th)}}{\Delta T_J}$ $R_{DS(on)}$ $\frac{g_{FS}}{DYNAMIC~CH}$	Temperature Coefficient Static Drain to Source On–Resistance Forward Transconductance	$I_{D} = 9.0 \text{ A, } V_{GS} = 10 \text{ V,}$ $I_{D} = 8.5 \text{ A, } V_{GS} = 4.5 \text{ V}$ $I_{D} = 9.0 \text{ A, } V_{GS} = 10 \text{ V,}$ $T_{J} = 125^{\circ}\text{C}$	-	13 16	19	,
g _{FS} D ynamic C h C _{iss}	Forward Transconductance	I_D = 8.5 A, V_{GS} = 4.5 V I_D = 9.0 A, V_{GS} = 10 V, T_J = 125°C	-	16	19	mΩ
g _{FS} D YNAMIC CH C _{iss}		I _D = 9.0 A, V _{GS} = 10 V, T _J = 125°C	-	1		
OYNAMIC CH C _{iss}		T _J = 125°C		17	21	
OYNAMIC CH C _{iss}		V _{DD} = 5 V, I _D = 9.0 A			1	
C _{iss}	HARACTERISTICS		_	41	-	S
	Input Capacitance	$V_{DS} = -15 \text{ V}, V_{GS} = 0 \text{ V},$	-	539	720	pF
	Output Capacitance	f = 1.0 MHz	_	172	230	
C _{rss}	Reverse Transfer Capacitance		-	24	35	
R_{G}	Gate Resistance		_	1.3	_	Ω
WITCHING	CHARACTERISTICS					
t _{d(on)}	Turn-On Delay Time	V _{DD} = 15 V, I _D = 9.0 A,	_	6	12	ns
t _r	Rise Time	$V_{GS} = 10 \text{ V}, R_{GEN} = 6 \Omega$	_	2	10	
t _{d(off)}	Turn-Off Delay Time	7	_	14	25	
t _f	Fall Time		_	2	10	
Q _{g(TOT)} Total Gate Charge	Total Gate Charge	$V_{GS} = 0 \text{ V to } 10 \text{ V}, V_{DD} = 15 \text{ V}, I_D = 9.0 \text{ A}$	_	8.5	12	nC
		$V_{GS} = 0 \text{ V to } 4.5 \text{ V}, V_{DD} = 15 \text{ V}, I_D = 9.0 \text{ A}$	_	4.1	5.8	nC
Q_{gs}	Gate to Source Charge	V _{DD} = 15 V, I _D = 9.0 A	_	1.6	_	
Q_{qd}	Gate to Drain "Miller" Charge		-	1.2	-	
DRAIN-SOUI	RCE DIODE CHARACTERISTICS AND MA	AXIMUM RATINGS				
V_{SD}	Source to Drain Diode Forward Voltage	V _{GS} = 0 V, I _S = 2.0 A (Note 2)	-	0.75	1.2	V
		V _{GS} = 0 V, I _S = 9.0 A (Note 2)	-	0.86	1.2	
t _{rr}	Reverse Recovery Time	I _F = 9.0 A, di/dt = 100 A/μs	-	16	28	ns
Q _{rr}	Reverse Recovery Charge]	-	4	10	nC

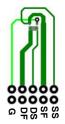
Product parametric performance is indicated in the Electrical Characteristics for the listed test conditions, unless otherwise noted. Product performance may not be indicated by the Electrical Characteristics if operated under different conditions.

NOTES:

1. $R_{\theta JA}$ is the sum of the junction-to-case and case-to-ambient thermal resistance where the case thermal reference is defined as the solder mounting surface of the drain pins. $R_{\theta,JC}$ is guaranteed by design while $R_{\theta,CA}$ is determined by the user's board design.



a) 52°C/W when mounted on a 1 in² pad of 2 oz. copper.



b) 145°C/W when mounted on a minimum pad of 2 oz copper.

- 2. Pulse Test: Pulse Width < 300 μ s, Duty Cycle < 2.0% 3. As an N-ch device, the negative V_{gs} rating is for low duty cycle pulse occurrence only. No continuous rating is implied.

TYPICAL CHARACTERISTICS

 $(T_J = 25^{\circ}C \text{ unless otherwise noted})$

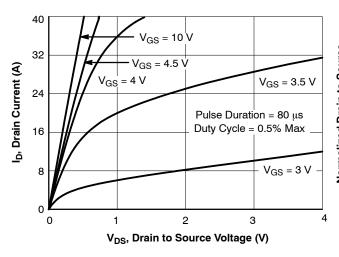


Figure 1. On-Region Characteristics

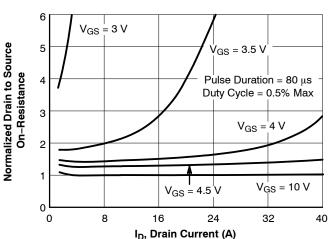


Figure 2. Normalized On–Resistance vs.
Drain Current and Gate Voltage

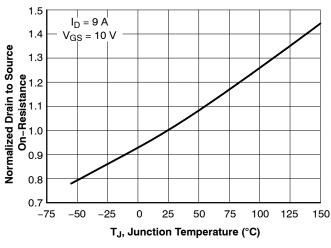


Figure 3. Normalized On–Resistance vs. Junction Temperature

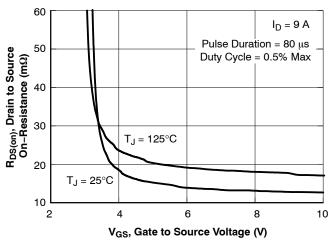


Figure 4. On-Resistance vs. Gate-to-Source Voltage

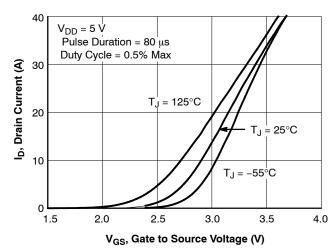


Figure 5. Transfer Characteristics

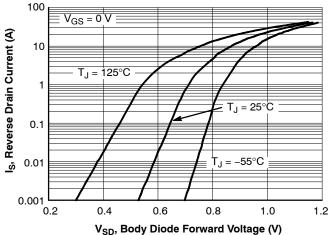


Figure 6. Body Diode Forward Voltage Variation with Source Current and Temperature

TYPICAL CHARACTERISTICS (continued)

(T_J = 25°C unless otherwise noted)

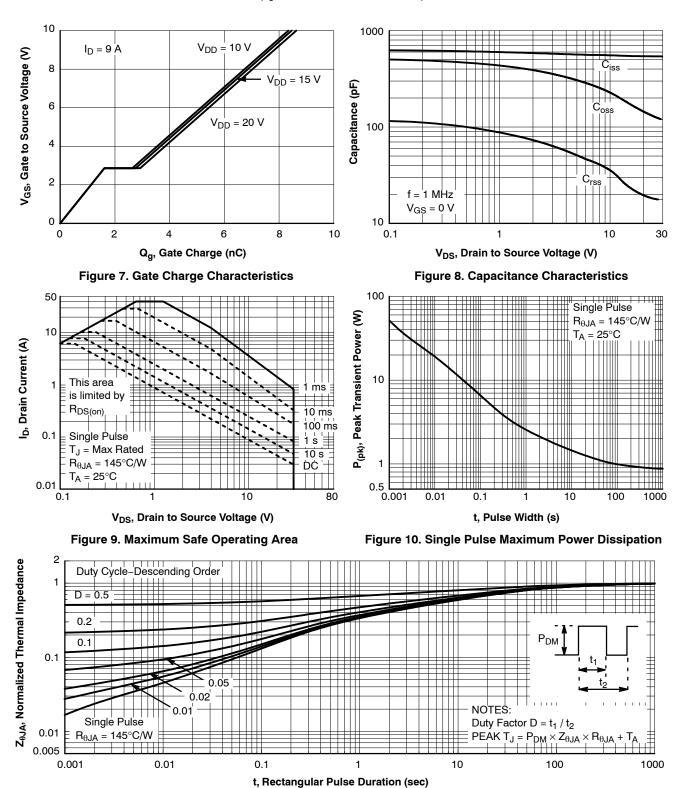


Figure 11. Transient Thermal Response Curve

Thermal characterization performed using the conditions described in Note 1b. Transient thermal response will change depending on the circuit board design.

ORDERING INFORMATION

Device Order Number	Package Type	Pin 1 Orientation in Tape Cavity	Shipping [†]
FDMA8878	WDFN6 (Pb-Free/Halide Free)	Top Left	3000 / Tape & Reel
FDMA8878-F130	WDFN6 (Pb-Free/Halide Free)	Top Right	3000 / Tape & Reel

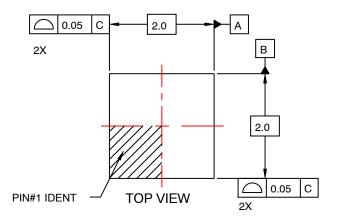
[†]For information on tape and reel specifications, including part orientation and tape sizes, please refer to our Tape and Reel Packaging Specifications Brochure, BRD8011/D.

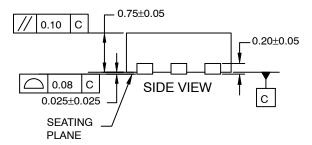
POWERTRENCH is a registered trademark of Semiconductor Components Industries, LLC dba "onsemi" or its affiliates and/or subsidiaries in the United States and/or other countries.

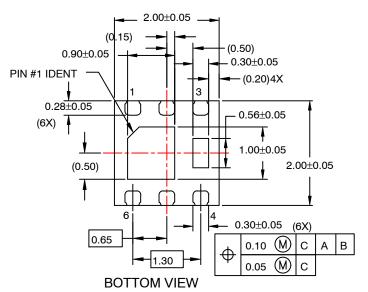


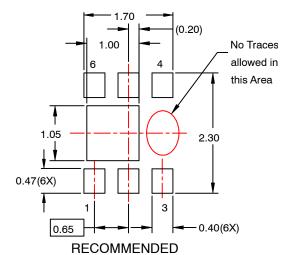
WDFN6 2x2, 0.65P CASE 511CZ ISSUE O

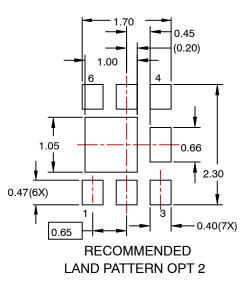
DATE 31 JUL 2016











LAND PATTERN OPT 1

NOTES:

- A. PACKAGE DOES NOT FULLY CONFORM TO JEDEC MO-229 REGISTRATION
- B. DIMENSIONS ARE IN MILLIMETERS.
- C. DIMENSIONS AND TOLERANCES PER ASME Y14.5M, 2009.
- D. LAND PATTERN RECOMMENDATION IS EXISTING INDUSTRY LAND PATTERN.

DOCUMENT NUMBER:	98AON13614G	Electronic versions are uncontrolled except when accessed directly from the Document Repository. Printed versions are uncontrolled except when stamped "CONTROLLED COPY" in red.		
DESCRIPTION:	WDFN6 2X2, 0.65P		PAGE 1 OF 1	

onsemi and ONSEMI are trademarks of Semiconductor Components Industries, LLC dba onsemi or its subsidiaries in the United States and/or other countries. onsemi reserves the right to make changes without further notice to any products herein. onsemi makes no warranty, representation or guarantee regarding the suitability of its products for any particular purpose, nor does onsemi assume any liability arising out of the application or use of any product or circuit, and specifically disclaims any and all liability, including without limitation special, consequential or incidental damages. onsemi does not convey any license under its patent rights nor the rights of others.

onsemi, ONSEMI, and other names, marks, and brands are registered and/or common law trademarks of Semiconductor Components Industries, LLC dba "onsemi" or its affiliates and/or subsidiaries in the United States and/or other countries. onsemi owns the rights to a number of patents, trademarks, copyrights, trade secrets, and other intellectual property. A listing of onsemi's product/patent coverage may be accessed at www.onsemi.com/site/pdf/Patent-Marking.pdf. Onsemi reserves the right to make changes at any time to any products or information herein, without notice. The information herein is provided "as-is" and onsemi makes no warranty, representation or guarantee regarding the accuracy of the information, product features, availability, functionality, or suitability of its products for any particular purpose, nor does onsemi assume any liability arising out of the application or use of any product or circuit, and specifically disclaims any and all liability, including without limitation special, consequential or incidental damages. Buyer is responsible for its products and applications using **onsemi** products, including compliance with all laws, regulations and safety requirements or standards, regardless of any support or applications information provided by **onsemi**. "Typical" parameters which may be provided in **onsemi** data sheets and/or specifications can and do vary in different applications and actual performance may vary over time. All operating parameters, including "Typicals" must be validated for each customer application by customer's technical experts. **onsemi** does not convey any license under any of its intellectual property rights nor the rights of others. **onsemi** products are not designed, intended, or authorized for use as a critical component in life support systems or any FDA Class 3 medical devices or medical devices with a same or similar classification in a foreign jurisdiction or any devices intended for implantation in the human body. Should Buyer purchase or use **onsemi** products for any such unintended or unauthorized application, Buyer shall indemnify and hold **onsemi** and its officers, employees, subsidiaries, affiliates, and distributors harmless against all claims, costs, damages, and expenses, and reasonable attorney fees arising out of, directly or indirectly, any claim of personal injury or death associated with such unintended or unauthorized use, even if such claim alleges that **onsemi** was negligent regarding the design or manufacture of the part. **onsemi** is an Equal Opportunity/Affirmative Action Employer. This literature is subject to all applicable copyright laws and is not for resale in any manner.

ADDITIONAL INFORMATION

TECHNICAL PUBLICATIONS:

 $\textbf{Technical Library:} \ \underline{www.onsemi.com/design/resources/technical-documentation}$

onsemi Website: www.onsemi.com

ONLINE SUPPORT: www.onsemi.com/support

For additional information, please contact your local Sales Representative at

www.onsemi.com/support/sales